TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# **TC74HC390AP, TC74HC390AF**

#### Dual Decade Counter

The TC74HC390A is a high speed CMOS DUAL DECADE COUNTER fabricated with silicon gate  $C^2MOS$  technology.

It achieves the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

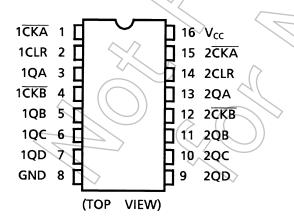
It consists of two independent 4-bit counters, each composed of a divide-by-two and a divide-by-five counter. The divide-by-two counter is incremented on the negative going transition of clock A ( $\overline{\text{CKA}}$ ). The divided-by-five counter is incremented on the negative going transition of clock B ( $\overline{\text{CKB}}$ ). The counter can be cascaded to form decade, bi-quinary, or various combinations up to a divide-by-100 counter. When the CLR input is set high, the Q outputs are set to low independent of the clock inputs.

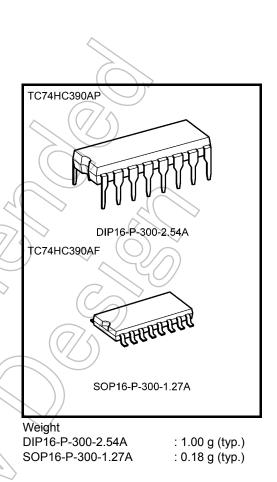
All inputs are equipped with protection circuits against static discharge or transient excess voltage.

## Features

- High speed:  $f_{max} = 84$  MHz (typ.) at  $V_{CC} = 5$  V
- Low power dissipation:  $I_{CC} = 4 \mu A (max)$  at  $Ta = 25^{\circ}C$
- High noise immunity:  $V_{\text{NIH}} = V_{\text{NIL}} = 28\% V_{\text{CC}}$  (min)
- Output drive capability: 10 LSTTL loads
- Symmetrical output impedance:  $|I_{OH}| = I_{OL} = 4 \text{ mA} (\text{min})$
- Balanced propagation delays:  $t_{pLH} \simeq t_{pHL}$
- Wide operating voltage range:  $V_{CC}$  (opr) = 2 to 6 V
- Pin and function compatible with 74LS390

## **Pin Assignment**

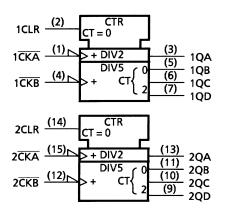




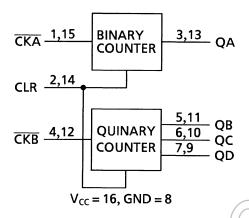
Start of commercial production 1986-11

## **TOSHIBA**

## **IEC Logic Symbol**



## **Block Diagram**



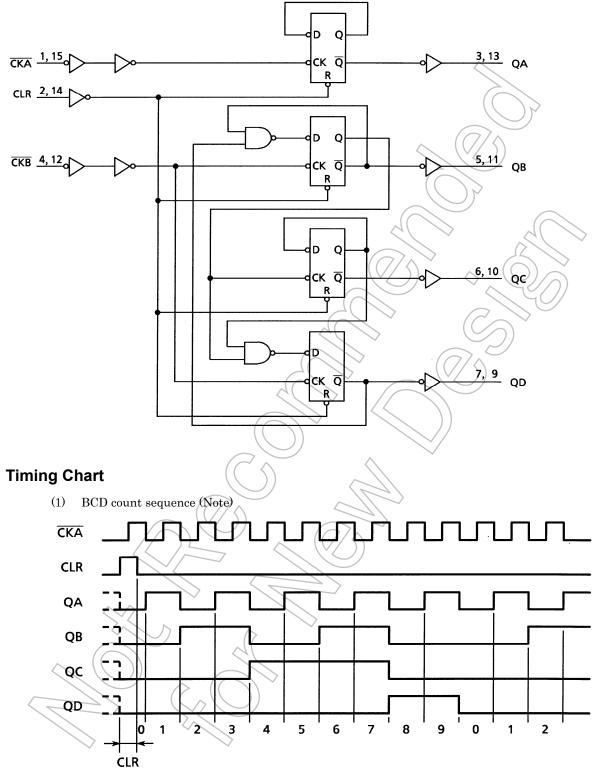
## **Truth Table**

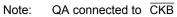
|        | able   |                           |                           | ((  | 77   | <u> </u> |  |  |  |
|--------|--------|---------------------------|---------------------------|-----|------|----------|--|--|--|
|        | Inputs |                           | $\int \int \int dx dx dx$ | Out | puts |          |  |  |  |
| CKA    | CKB    | CLR                       | QA                        | QB  | QC   | QD       |  |  |  |
| Х      | Х      | Н                         |                           | ζL  | L    | Ļ        |  |  |  |
| $\neg$ | х      | L                         | Binary Count Up           |     |      |          |  |  |  |
| Х      |        | $\langle \langle \rangle$ | Quinary Count Up          |     |      |          |  |  |  |
|        |        | $\langle \wedge$          | \                         |     |      | $\sim$   |  |  |  |

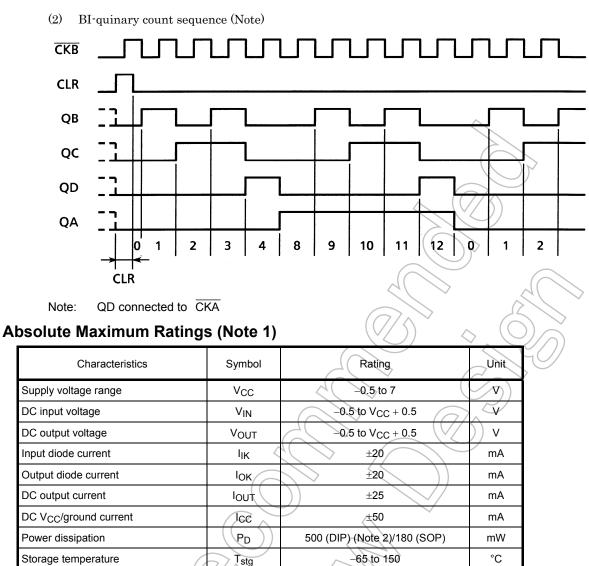
X: Don't care

TOSHIBA

## System Diagram (1/2 package)







Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: 500 mW in the range of Ta = -40 to 65°C. From Ta = 65 to 85°C a derating factor of -10 mW/°C shall be applied until 300 mW.

## **Operating Ranges (Note)**

| Characteristics          | Symbol                          | Rating                                | Unit |
|--------------------------|---------------------------------|---------------------------------------|------|
| Supply voltage           | V <sub>CC</sub>                 | 2 to 6                                | V    |
| Input voltage            | V <sub>IN</sub>                 | 0 to V <sub>CC</sub>                  | V    |
| Output voltage           | Vout                            | 0 to V <sub>CC</sub>                  | V    |
| Operating temperature    | T <sub>opr</sub>                | -40 to 85                             | °C   |
|                          |                                 | 0 to 1000 (V <sub>CC</sub> = 2.0 V)   |      |
| Input rise and fall time | t <sub>r</sub> , t <sub>f</sub> | 0 to 500 (V_{CC} = 4.5 V)             | ns   |
|                          |                                 | 0 to 400 ( $V_{CC} = 6.0 \text{ V}$ ) |      |

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either  $V_{CC}$  or GND.

## **Electrical Characteristics**

#### **DC Characteristics**

| Characteristics                          | Symbol          | Test Condition  |                            | ٦           | Га = 25°С | 2                       | Ta = -40 to 85°C |      | Unit       |      |
|--|-----------------|---|----------------------------|-------------|-----------|-------------------------|------------------|------|------------|------|
| Symbol Symbol                            |                 |   |                            | $V_{CC}(V)$ | Min       | Тур.                    | Max              | Min  | Max        | Unit |
|  |                 |   |                            | 2.0         | 1.50      | - <                     |                  | 1.50 | _          |      |
| High-level input<br>voltage              | VIH             |   | _                          | 4.5         | 3.15      | —                       | $\geq$           | 3.15 | _          | V    |
|  |                 |   |                            | 6.0         | 4.20      | —                       | $( \sub$         | 4.20 | _          |      |
|  |                 |   |                            |             | _         |                         | 0.50             | 2_   | 0.50       |      |
| Low-level input voltage                  | VIL             |   | _                          | 4.5         |           |                         | 1,35             | —    | 1.35       | V    |
| J. J |                 |   |                            | 6.0         |           | $\langle \cdot \rangle$ | 1.80             |      | 1.80       |      |
|  | V <sub>OH</sub> | V <sub>IN</sub><br>= V <sub>IH</sub> or V <sub>IL</sub> |                            | 2.0         | 1.9( (    | 2.0                     | > —              | 1.9  | —          |      |
|  |                 |   | $I_{OH} = -20 \ \mu A$     | 4.5         | 4.4       | 4.5                     | —                | 4.4  | —          |      |
| High-level output<br>voltage             |                 |   |                            | 6.0         | 5.9       | 6.0                     | _                | 5.9  | $\searrow$ | V    |
| Ū.                                       |                 |   | I <sub>OH</sub> = -4 mA    | 4.5         | 4.18      | 4.31                    | - (              | 4.13 | <u> </u>   |      |
|  |                 |   | $I_{OH} = -5.2 \text{ mA}$ | 6.0         | 5.68      | 5.80                    | -(               | 5.63 | ~ _        |      |
|  | V <sub>OL</sub> | V <sub>IN</sub><br>= VI <sub>H</sub> or VIL             |                            | 2.0         | 2         | 0.0                     | 0.1              | KA)  | 0.1        |      |
|  |                 |   | I <sub>OL</sub> = 20 μA    | 4.5         | —         | 0.0                     | 0.1              | 52   | 0.1        |      |
| Low-level output<br>voltage              |                 |   | 20                         | 6.0         | _         | 0.0                     | 0.1              | × —  | 0.1        | V    |
|  |                 |   | $I_{OL} = 4 \text{ mA}$    | 4.5         | —         | 0.17                    | 0.26             | _    | 0.33       |      |
|  |                 |   | I <sub>OL</sub> = 5.2 mA   | 6.0         | _         | 0.18                    | 0.26             |      | 0.33       |      |
| Input leakage<br>current                 | I <sub>IN</sub> | $V_{IN} = V_{CC}$ or                                    | GND                        | 6.0         |           |                         | ±0.1             | _    | ±1.0       | μA   |
| Quiescent supply current                 | ICC             | VIN = V <sub>CC</sub> or                                | GND                        | 6.0         | X         | ))_                     | 4.0              | _    | 40.0       | μΑ   |

## Timing Requirements (input: $t_r = t_f = 6$ ns)

| Characteristics      | Symbol     | Test Condition        | Test Condition      |      |       | Ta =<br>-40 to<br>85°C | Unit |  |
|----------------------|------------|-----------------------|---------------------|------|-------|------------------------|------|--|
|                      |            | $\sim$ (7/ $\diamond$ | V <sub>CC</sub> (V) | Тур. | Limit | Limit                  |      |  |
| Minimum pulse width  |            |                       | 2.0                 | _    | 75    | 95                     |      |  |
| (CK)                 | tw (H)     |                       | 4.5                 | —    | 15    | 19                     | ns   |  |
|                      | tw (L)     |                       | 6.0                 | —    | 13    | 16                     |      |  |
| Minimum pulse width  |            |                       | 2.0                 | _    | 75    | 95                     |      |  |
|                      | tw (H)     | —                     | 4.5                 | —    | 15    | 19                     | ns   |  |
| (CLR)                | 90         |                       | 6.0                 | —    | 13    | 16                     |      |  |
|                      | $\square$  | $\supset$             | 2.0                 | _    | 25    | 30                     |      |  |
| Minimum removal time | trem       | _                     | 4.5                 | —    | 5     | 6                      | ns   |  |
|                      |            |                       | 6.0                 | —    | 5     | 5                      |      |  |
| Clock frequency      | $\searrow$ |                       | 2.0                 | _    | 6     | 5                      |      |  |
|                      | f          | —                     | 4.5                 | —    | 32    | 26                     | MHz  |  |
| (UNA)                |            |                       | 6.0                 | —    | 38    | 31                     |      |  |
| Cleak fraguenau      |            |                       | 2.0                 | _    | 6     | 5                      |      |  |
| Clock frequency      | f          | —                     | 4.5                 | —    | 31    | 25                     | MHz  |  |
| ( <del>CKB</del> )   |            |                       | 6.0                 | _    | 36    | 29                     |      |  |

## AC Characteristics (C<sub>L</sub> = 15 pF, V<sub>CC</sub> = 5 V, Ta = 25°C input: $t_r = t_f = 6$ ns)

| Characteristics         | Symbol           | Test Condition            | Min          | Тур. | Max | Unit  |
|-------------------------|------------------|---------------------------|--------------|------|-----|-------|
| Output transition time  | t <sub>TLH</sub> | _                         |              | 4    | 8   | ns    |
| Output transition time  | t <sub>THL</sub> |                           |              | -    | 0   | 113   |
| Propagation delay time  | t <sub>pLH</sub> |                           |              | 10   | 20  | 20    |
| ( CKA -QA)              | t <sub>pHL</sub> | _                         | $\geq$       | 10   | 20  | ns    |
| Propagation delay time  | t <sub>pLH</sub> | QA connected to CKB       | (            | 29   | 51  | ns    |
| ( CKA -QC)              | t <sub>pHL</sub> | CA connected to CKB       |              | 29   | 51  | 115   |
| Propagation delay time  | t <sub>pLH</sub> |                           | $\mathbb{Z}$ | 12   | 22  | ns    |
| ( CKB -QB, QD)          | t <sub>pHL</sub> |                           | T            | 12   | 22  | 115   |
| Propagation delay time  | t <sub>pLH</sub> |                           | >            | 17   | 32  | ns    |
| ( CKB -QC)              | t <sub>pHL</sub> | _                         |              |      | 52  | 115   |
| Propagation delay time  | <b>*</b>         | $\mathcal{A}(\mathbb{N})$ |              | 12   | 26  | 20    |
| (CLR-Qn)                | t <sub>pHL</sub> | _                         |              |      | 20  | ns    |
| Maximum clock frequency | £                |                           | 35           |      | 7   | MHz   |
| ( <del>CKA</del> )      | f <sub>max</sub> |                           | 35           | 84   | ) — | IVITZ |
| Maximum clock frequency | f                |                           | 33           | 65   |     | MHz   |
| ( <del>CKB</del> )      | f <sub>max</sub> |                           | 33           | ~ 05 | _   | IVITZ |

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## AC Characteristics ( $C_L = 50 \text{ pF}$ , input: $t_r = t_f = 6 \text{ ns}$ )

| Characteristics               | Symbol                    | Test Condition               |             | -             | Га = 25°С | 2   | Ta = -40 to 85°C  |     | Unit |
|-------------------------------|---------------------------|------------------------------|-------------|---------------|-----------|-----|-------------------|-----|------|
| Characteristics               | Symbol                    |                              | $V_{CC}(V)$ | Min           | Тур.      | Max | Min               | Max | Unit |
|                               | t                         |                              | 2.0         | _             | 30        | 75  |                   | 95  |      |
| Output transition time        | t⊤LH                      | —                            | 4.5         | —             | 8         | 15  | —                 | 19  | ns   |
|                               | t⊤HL                      |                              | 6.0         | —             | 7 <       | 13  |                   | 16  |      |
| Propagation delay             | t <sub>pLH</sub>          |                              | 2.0         |               | 39        | 120 | 1                 | 150 |      |
| time                          | •                         | —                            | 4.5         | —             | 13        | 24  | )/                | 30  | ns   |
| ( <del>CKA</del> -QA)         | tpHL                      |                              | 6.0         |               | 11        | 20  | _                 | 26  |      |
| Propagation delay             | t <sub>pLH</sub>          |                              | 2.0         | $ \leq $      | 102       | 290 |                   | 365 |      |
| time                          |                           | QA connected to CKB          | 4.5         | - (           | 34        | 58  | —                 | 73  | ns   |
| (CKA -QC)                     | t <sub>pHL</sub>          |                              | 6.0         | (             | 29        | 49  |                   | 62  |      |
| Propagation delay             | t <sub>pLH</sub>          |                              | 2.0         |               | 45        | 130 | (                 | 165 |      |
| time                          | •                         | —                            | 4.5 <       |               | 15        | 26  | Æ                 | 33  | ns   |
| $(\overline{CKB} - QB, QD)$   | t <sub>pHL</sub>          |                              | 6.0         |               | 13        | 22  |                   | 28  |      |
| Propagation delay             | t <sub>pLH</sub>          |                              | 2.0         | $\rightarrow$ | 63        | 185 | $D \rightarrow a$ | 230 |      |
| time                          | t <sub>pHL</sub>          | - (                          | 4.5         |               | 21        | 37  | GC/               | 46  | ns   |
| (CKB-QC)                      | φnL                       | G                            | 6.0         | —             | 18        | 31  | $\geq$ $-$        | 39  |      |
| Propagation delay             |                           |                              | 2.0         | —             | 45        | 150 |                   | 190 |      |
| time                          | t <sub>pHL</sub>          | - (                          | 4.5         | —             | 15        | 30  |                   | 38  | ns   |
| (CLR-Qn)                      |                           |                              | 6.0         |               | 13        | 26  | —                 | 32  |      |
| Maximum clock                 |                           | $\langle \langle \rangle$    | 2.0         | 6             | 20        | —   | 5                 | —   |      |
| frequency                     | f <sub>max</sub>          |                              | 4.5         | 32            | ) 77      | —   | 26                | —   | MHz  |
| ( <del>CKA</del> )            |                           |                              | 6.0         | 38            | 90        | —   | 31                |     |      |
| Maximum clock                 |                           | $\overline{C}$               | 2.0         | 6             | 15        | —   | 5                 | —   |      |
| frequency                     | f <sub>max</sub>          | (())                         | 4.5         | 32            | 60        | —   | 25                | —   | MHz  |
| ( <del>CKB</del> )            |                           |                              | 6.0         | 36            | 70        | —   | 29                |     |      |
| Input capacitance             | GIN                       | $\langle \rangle \rangle - $ | 2           | _             | 5         | 10  |                   | 10  | pF   |
| Power dissipation capacitance | C <sub>PD</sub><br>(Note) |                              | )           |               | 44        | _   |                   |     | pF   |

Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

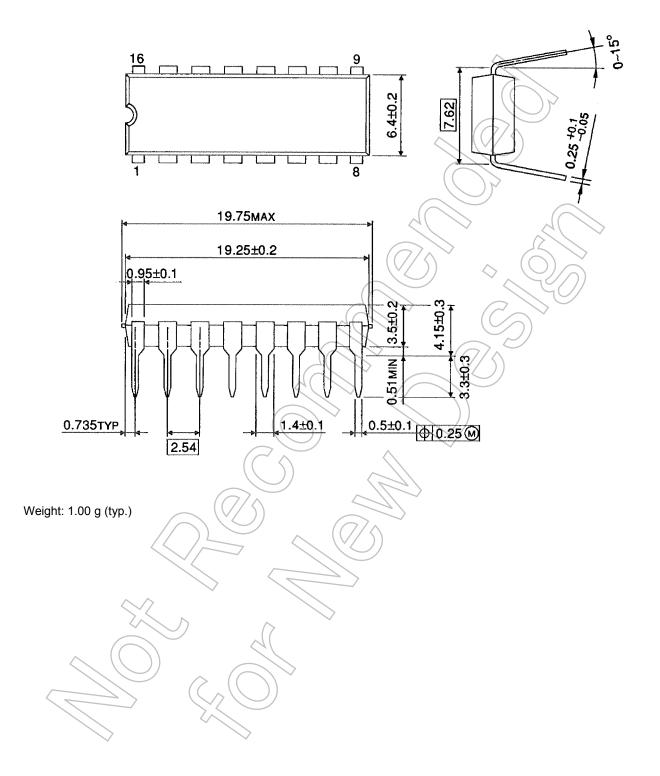
Average operating current can be obtained by the equation:

 $I_{CC}$  (opr) =  $C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/2$  (per counter)

### **Package Dimensions**

DIP16-P-300-2.54A

Unit : mm

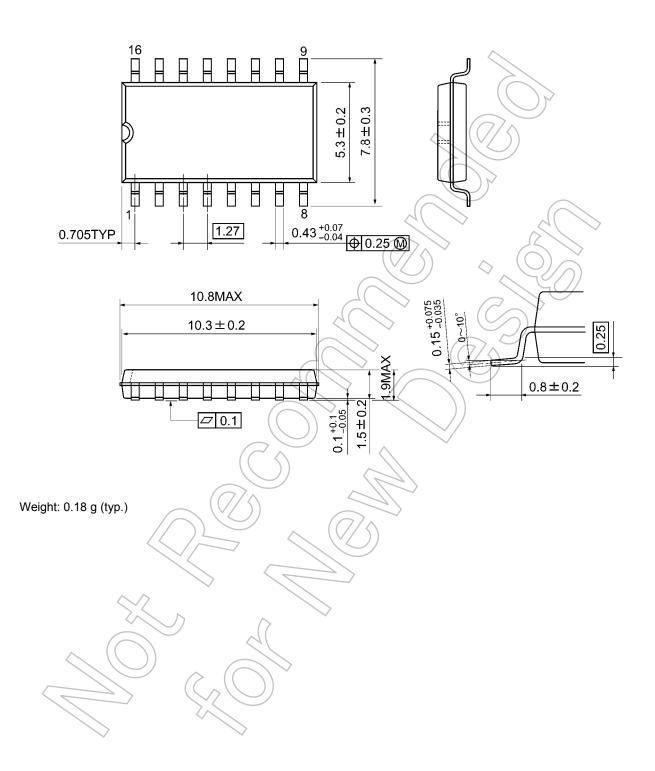




### **Package Dimensions**

SOP16-P-300-1.27A

Unit: mm



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